



### DUAL MIDDLE POWER MOSFET (N-CHANNEL/P-CHANNEL)

#### DESCRIPTION

The UTC **UT30NP04** incorporates an N-channel MOSFET and a P-channel MOSFET, it uses UTC's advanced technology to provide customers a minimum on-state resistance and high-speed switching, thereby enabling high-density mounting.

#### FEATURES

\* N-Channel

$R_{DS(on)} \leq 40 \text{ m}\Omega @ V_{GS}=10V, I_D=15A$

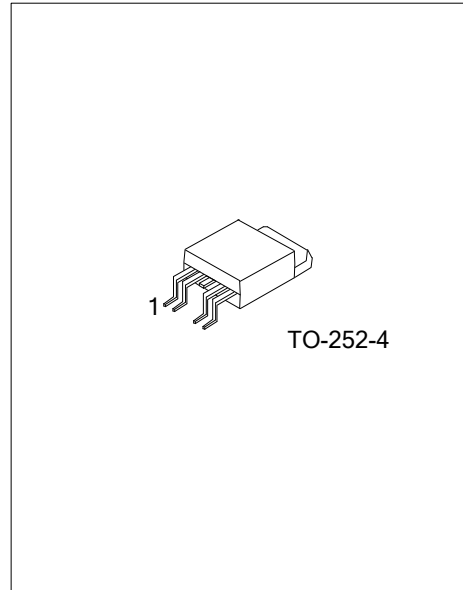
$R_{DS(on)} \leq 60 \text{ m}\Omega @ V_{GS}=4.5V, I_D=15A$

\* P-Channel

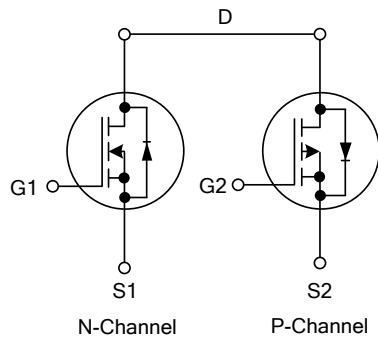
$R_{DS(on)} \leq 50 \text{ m}\Omega @ V_{GS}=-10V, I_D=-15A$

$R_{DS(on)} \leq 80 \text{ m}\Omega @ V_{GS}=-4.5V, I_D=-15A$

\* High switching speed



#### SYMBOL



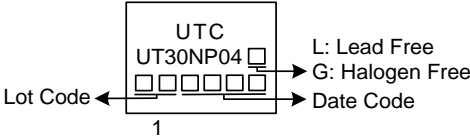
#### ORDERING INFORMATION

Ordering Number		Package	Pin Assignment					Packing
Lead Free	Halogen Free		1	2	3	4	5	
UT30NP04L-TN4-R	UT30NP04G-TN4-R	TO-252-4	S1	G1	D	S2	G2	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

<p>UT30NP04G-TN4-R</p> <p>(1)Packing Type</p> <p>(2)Package Type</p> <p>(3)Green Package</p>	<p>(1) R: Tape Reel</p> <p>(2) TN4: TO-252-4</p> <p>(3) G: Halogen Free and Lead Free, L: Lead Free</p>
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■ **MARKING**



### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS		UNIT	
		N-CH	P-CH		
Drain-Source Voltage	V <sub>DSS</sub>	40	-40	V	
Gate-Source Voltage	V <sub>GSS</sub>	±20	±20	V	
Drain Current	Continuous T <sub>C</sub> =25°C	I <sub>D</sub>	30	-30	A
	Pulsed	I <sub>DM</sub>	40	-40	A
Avalanche Energy, Single Pulse	E <sub>AS</sub>	16	190	mJ	
Power Dissipation (T <sub>A</sub> =25°C)	P <sub>D</sub>	50		W	
Junction Temperature	T <sub>J</sub>	+150		°C	
Range of Storage Temperature	T <sub>STG</sub>	-55 ~ +150		°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature.

3. N-Channel: L=0.5mH, I<sub>AS</sub>=8.1A, V<sub>DD</sub>=40V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25°C

P-Channel: L=0.5mH, I<sub>AS</sub>=-27.6A, V<sub>DD</sub>=-40V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25°C

### ■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ <sub>JA</sub>	110	°C/W
Junction to Case	θ <sub>JC</sub>	25 (Note)	°C/W

Note: The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

### ■ ELECTRICAL CHARACTERISTICS (T<sub>J</sub>=25°C, unless otherwise specified)

#### N-CHANNEL

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	40			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V			1	μA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0		3.0	V
Static Drain-Source On-State Resistance (Pulsed)	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =15A			40	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =15A			60	mΩ
<b>DYNAMIC PARAMETERS</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		390		pF
Output Capacitance	C <sub>OSS</sub>			51		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			43		pF
<b>SWITCHING PARAMETERS</b>						
Total Gate Charge (Pulsed)	Q <sub>G</sub>	V <sub>DS</sub> =32V, V <sub>GS</sub> =10V, I <sub>D</sub> =30A I <sub>G</sub> =1mA (Note 1, 2)		12		nC
Gate to Source Charge (Pulsed)	Q <sub>GS</sub>			1.8		nC
Gate to Drain Charge (Pulsed)	Q <sub>GD</sub>			2		nC
Turn-ON Delay Time (Pulsed)	t <sub>D(ON)</sub>	V <sub>DS</sub> =20V, V <sub>GS</sub> =10V, I <sub>D</sub> =30A, R <sub>G</sub> =3.3Ω (Note 1, 2)		3		ns
Rise Time (Pulsed)	t <sub>R</sub>			15		ns
Turn-OFF Delay Time (Pulsed)	t <sub>D(OFF)</sub>			12		ns
Fall-Time (Pulsed)	t <sub>F</sub>			20		ns
<b>SOURCE TO DRAIN DIODE SPECIFICATIONS</b>						
Maximum Continuous Drain-Source Diode Forward Current	I <sub>S</sub>				30	A
Maximum Pulsed Drain-Source Diode Forward Current	I <sub>SM</sub>				40	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =30A, V <sub>GS</sub> =0V			1.3	V
Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =30A, V <sub>GS</sub> =0V di/dt=100A/μs		21		ns
Reverse Recovery Charge	Q <sub>rr</sub>				18	

Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%.

2. Essentially independent of operating temperature.

### ■ ELECTRICAL CHARACTERISTICS (Cont.)

#### P-CHANNEL

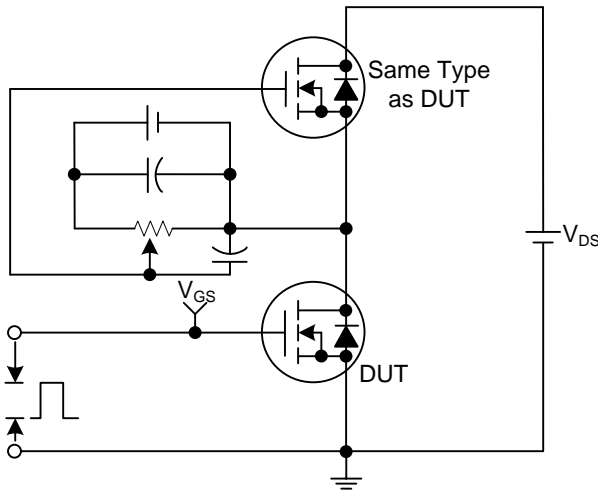
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$I_D = -250\mu A, V_{GS} = 0V$	-40			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -40V, V_{GS} = 0V$			-1	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1.0		-3.0	V
Static Drain-Source On-State Resistance (Pulsed)	$R_{DS(ON)}$	$V_{GS} = -10V, I_D = -15A$			50	m $\Omega$
		$V_{GS} = -4.5V, I_D = -15A$			80	m $\Omega$
<b>DYNAMIC PARAMETERS</b>						
Input Capacitance	$C_{ISS}$	$V_{GS} = 0V, V_{DS} = -25V, f = 1.0MHz$		1100		pF
Output Capacitance	$C_{OSS}$			130		pF
Reverse Transfer Capacitance	$C_{RSS}$			107		pF
<b>SWITCHING PARAMETERS</b>						
Total Gate Charge (Pulsed)	$Q_G$	$V_{DS} = -32V, V_{GS} = -10V, I_D = -30A$ (Note 1, 2)		25		nC
Gate to Source Charge (Pulsed)	$Q_{GS}$			3.5		nC
Gate to Drain Charge (Pulsed)	$Q_{GD}$			4.8		nC
Turn-ON Delay Time (Pulsed)	$t_{D(ON)}$	$V_{DS} = -20V, V_{GS} = -10V, I_D = -30A,$ $R_G = 3.3\Omega$ (Note 1, 2)		8		ns
Rise Time (Pulsed)	$t_R$			17		ns
Turn-OFF Delay Time (Pulsed)	$t_{D(OFF)}$			38		ns
Fall-Time (Pulsed)	$t_F$			24		ns
<b>SOURCE TO DRAIN DIODE SPECIFICATIONS</b>						
Maximum Continuous Drain-Source Diode Forward Current	$I_S$				-30	A
Maximum Pulsed Drain-Source Diode Forward Current	$I_{SM}$				-40	A
Diode Forward Voltage	$V_{SD}$	$I_S = -30A, V_{GS} = 0V$			-1.3	V
Reverse Recovery Time (Note 1)	$t_{rr}$	$I_S = -30A, V_{GS} = 0V, di/dt = 100A/\mu s$		52		ns
Reverse Recovery Charge	$Q_{rr}$			119		nC

Notes: 1. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ .

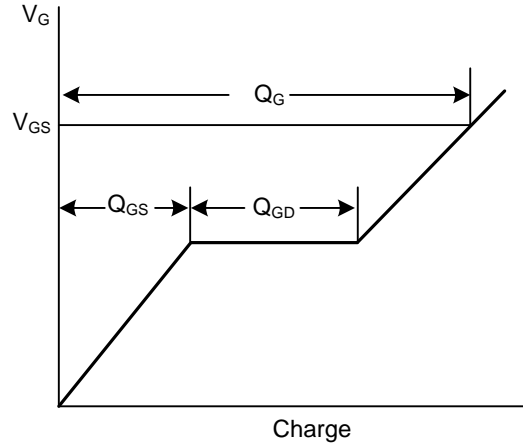
2. Essentially independent of operating temperature.

TEST CIRCUITS AND WAVEFORMS

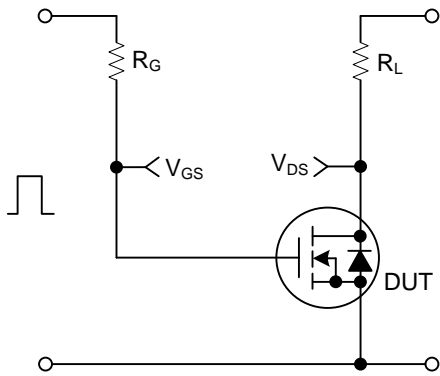
N-CHANNEL



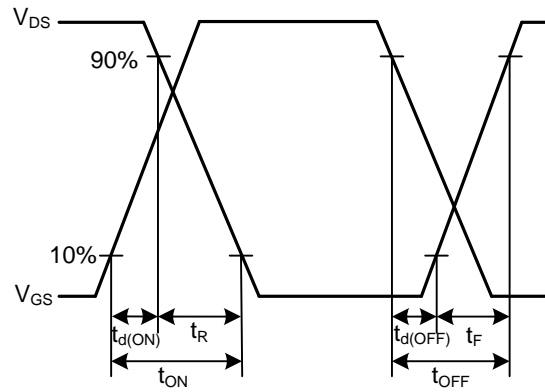
Gate Charge Test Circuit



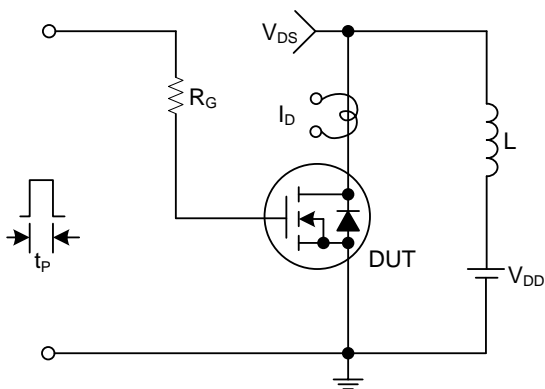
Gate Charge Waveforms



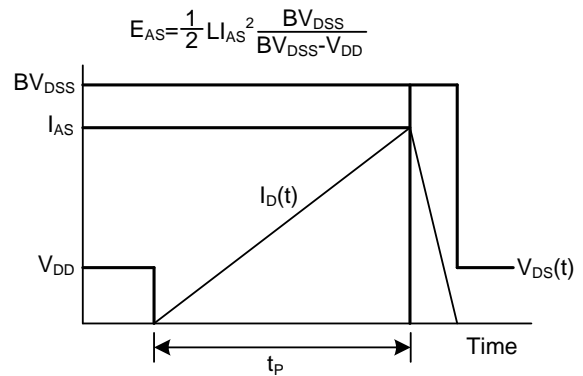
Resistive Switching Test Circuit



Resistive Switching Waveforms



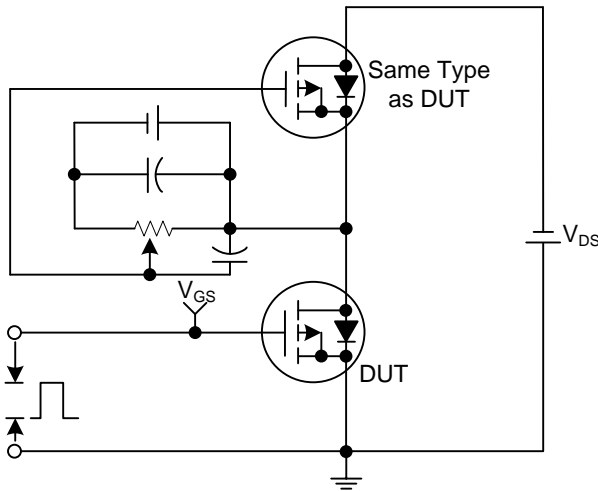
Unclamped Inductive Switching Test Circuit



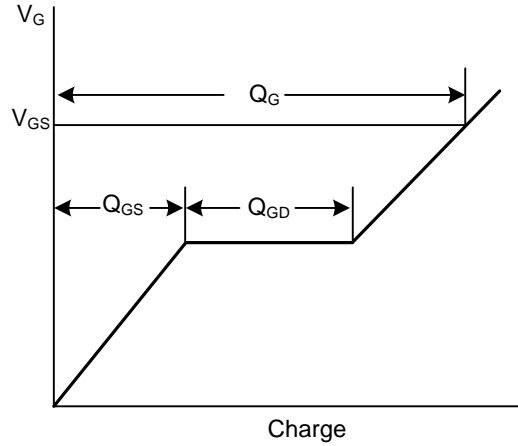
Unclamped Inductive Switching Waveforms

■ TEST CIRCUITS AND WAVEFORMS

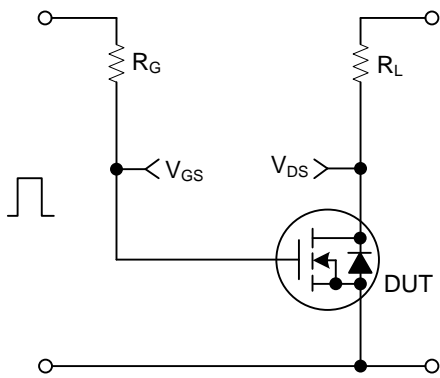
P-CHANNEL



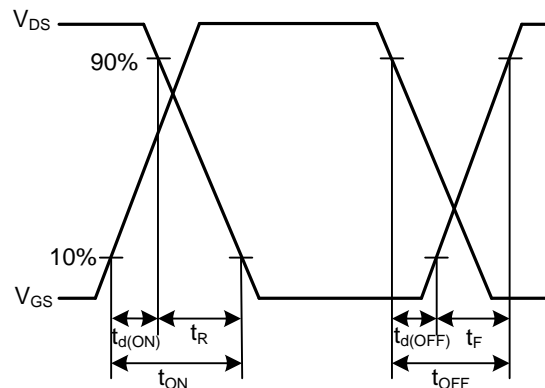
Gate Charge Test Circuit



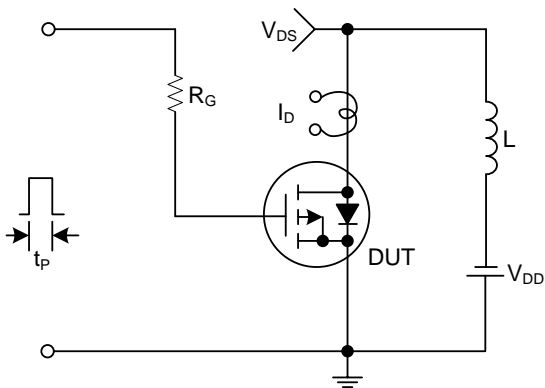
Gate Charge Waveforms



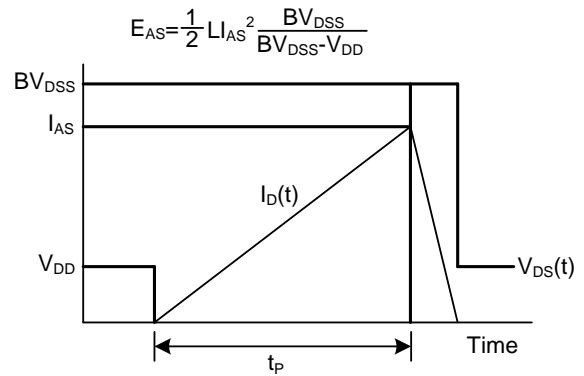
Resistive Switching Test Circuit



Resistive Switching Waveforms



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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